

Notice of References Cited	Applicant/Patent Shepard	Application/Control No. 09/453,319	
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U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
A	6286206B1	09.11.01	Li	29	840
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages				
U	H.I. McHenry. A Compliance Method for Crack Growth Studies at Elevated Temperature. Journal of Materials, JMLSA, Vol. 6, No. 4, pages 862-873. Dec. 1971				
V					
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* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.